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						APPLICANT Micro	soft Corporat	tion			
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	AR		"Methodology for I	Marking Objects	Listing a Polar Coordinate Point and Sh	nost Cursor # IRM9 Tec	taical Disclor	cure Ru	ileeln V	ol IS No 4	
111			"Methodology for Marking Objects Using a Polar Coordinate Point and Shoot Cursor," IBM® Technical Disciosure Bulletin, Vol. 35, No. 6, November 1992, pp. 310-311							•	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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				APPLICANT Microsoft Corporation							
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